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May 2014

FQA46N15

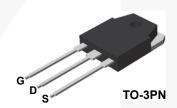
N-Channel QFET $^{\circledR}$ MOSFET 150 V, 50 A, 42 m Ω

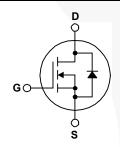
Features

- 50 A, 150 V, $R_{DS(on)}$ = 42 m Ω (Max) @ V_{GS} = 10 V, I_D = 25 A
- Low Gate Charge (Typ. 85 nC)
- Low Crss (Typ. 100 pF)
- · 100% Avalanche Tested
- 175°C Maximum Junction Temperature Rating

Description

This N-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, audio amplifier, DC motor control, and variable switching power applications.





Absolute Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol	Parameter		FQA46N15	Unit	
V _{DSS}	Drain-Source Voltage		150	V	
I _D	Drain Current - Continuous (T _C = 25°C)		50	Α	
	- Continuous (T _C = 100°C)		35.3	Α	
I _{DM}	Drain Current - Pulsed	(Note 1)	200	Α	
V _{GSS}	Gate-Source Voltage		± 25	V	
E _{AS}	Single Pulsed Avalanche Energy		650	mJ	
I _{AR}	Avalanche Current	(Note 1)	50	A	
E _{AR}	Repetitive Avalanche Energy (Note		25	mJ	
dv/dt	Peak Diode Recovery dv/dt (Note 3)		6.0	V/ns	
P_{D}	Power Dissipation (T _C = 25°C)		250	W	
	- Derate above 25°C		1.67	W/°C	
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +175	°C	
T _L	Maximum Lead Temperature for Soldering, 1/8 from Case for 5 Seconds		300	°C	

Thermal Characteristics

Symbol	Parameter	FQA46N15	Unit	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	0.6	°C/W	
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink, Typ.	0.24	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Max.	40	°C/W	

Package Marking and Ordering Information

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FQA46N15	FQA46N15	TO-3PN	Tube	N/A	N/A	30 units

Electrical Characteristics T_C = 25°C unless otherwise noted.

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Charac	teristics			I		I.
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	150			V
$\Delta BV_{DSS}/$ ΔT_J	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C		0.16		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 150 V, V _{GS} = 0 V	1		1	μА
		V _{DS} = 120 V, T _C = 150°C	-		10	μА
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 25 V, V _{DS} = 0 V	-		100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -25 V, V _{DS} = 0 V	-		-100	nA
On Charact	eristics					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 25A	-	0.033	0.042	Ω
9 _{FS}	Forward Transconductance	V _{DS} = 40 V, I _D = 25A	-	36		S
Dynamic Cl	naracteristics			1	1	
C _{iss}	Input Capacitance	V _{DS} = 25 V, V _{GS} = 0 V,	\	2500	3250	pF
C _{oss}	Output Capacitance	f = 1.0 MHz		520	670	pF
C _{rss}	Reverse Transfer Capacitance		-	100	130	pF
Switching C	Characteristics				1	
t _{d(on)}	Turn-On Delay Time	V _{DD} = 75 V, I _D = 45.6A,		35	80	ns
t _r	Turn-On Rise Time	$R_G = 25 \Omega$		320	650	ns
t _{d(off)}	Turn-Off Delay Time			210	430	ns
t _f	Turn-Off Fall Time	(Note 4)		200	410	ns
Qg	Total Gate Charge	V _{DS} = 120 V, I _D = 45.6A,	/	85	110	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10 V	-/	15		nC
Q _{gd}	Gate-Drain Charge	(Note 4)	-	41		nC
Drain-Source	ce Diode Characteristics and Maximum Ratings				/	I.
I _S	Maximum Continuous Drain-Source Diode Forward Current				50	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current		-		200	Α
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S =50A	-		1.5	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _S = 45.6 A,	-	130		ns
Q _{rr}	Reverse Recovery Charge	$dI_F / dt = 100 A/\mu s$		0.55		μС

NOTES

^{1.} Repetitive rating: pulse-width limited by maximum junction temperature.

^{2.} L = 0.43 mH, I $_{AS}$ = 50 A, V $_{DD}$ = 25 V, R $_{G}$ = 25 $\Omega,$ starting T $_{J}$ = 25 $^{\circ}C.$

 $^{3.}I_{SD} \leq 46.6 \text{ A, di/dt} \leq 300 \text{ A/}\mu\text{s, V}_{DD} \leq BV_{DSS}\text{, starting T}_J = 25^{\circ}C.$

^{4.} Essentially independent of operating temperature typical characteristics.

Typical Performance Characteristics

Figure 1. On-Region Characteristics

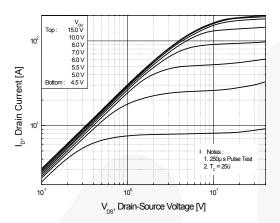


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

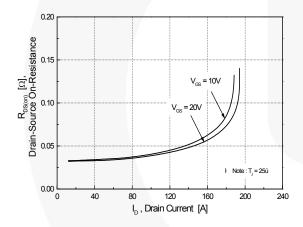


Figure 5. Capacitance Characteristics

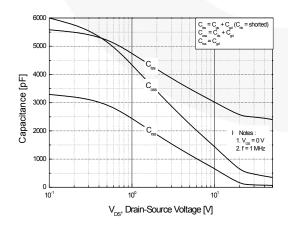


Figure 2. Transfer Characteristics

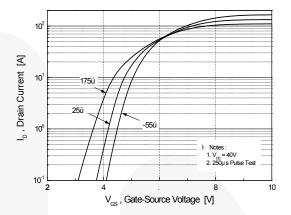


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperatue

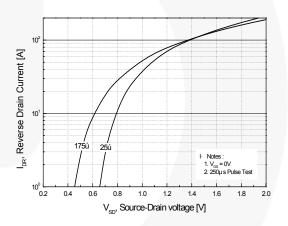
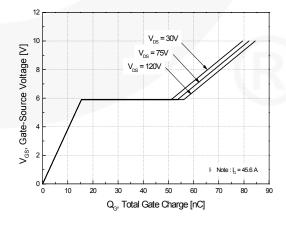


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

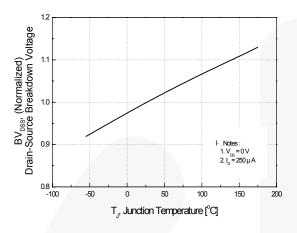


Figure 8. On-Resistance Variation vs. Temperature

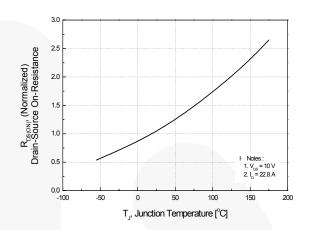


Figure 9. Maximum Safe Operating Area

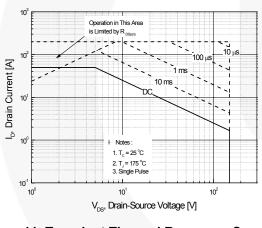


Figure 10. Maximum Drain Current vs. Case Temperature

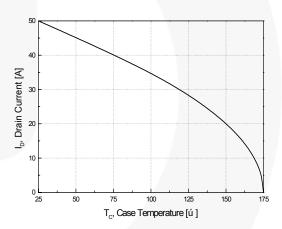
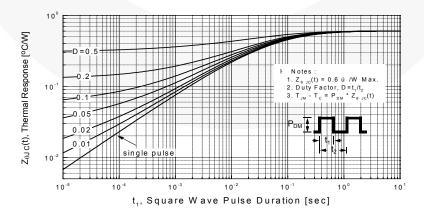


Figure 11. Transient Thermal Response Curve



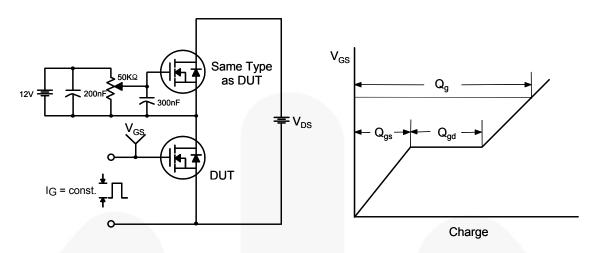


Figure 12. Gate Charge Test Circuit & Waveform

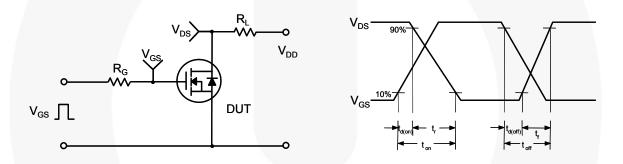


Figure 13. Resistive Switching Test Circuit & Waveforms

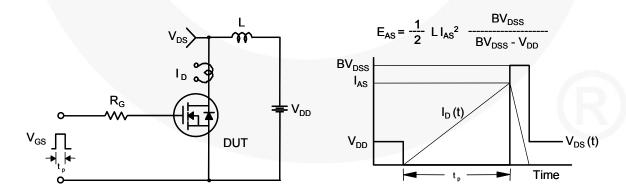


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms

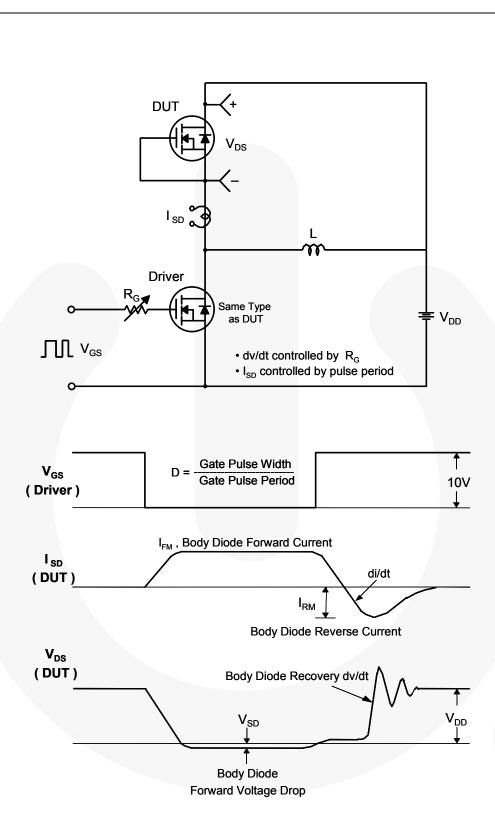


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

Mechanical Dimensions

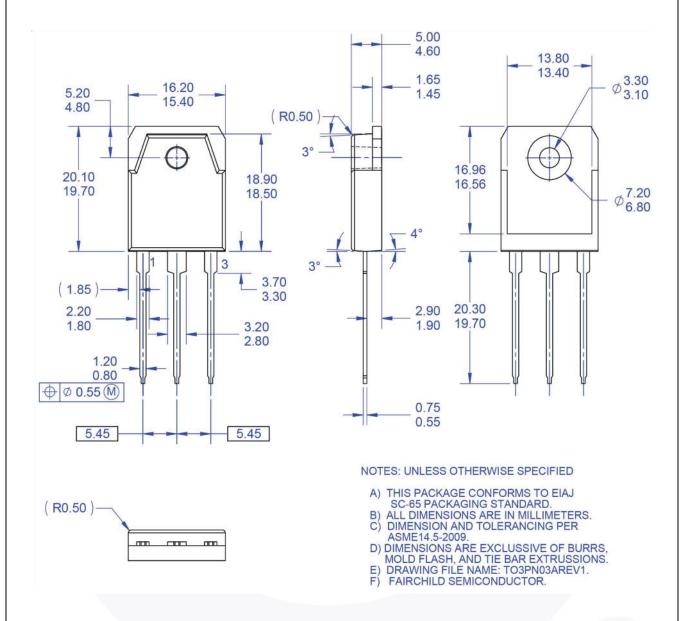


Figure 16. TO3PN, 3-Lead, Plastic, EIAJ SC-65

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